



Product data sheet

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Features

- 4 Unidirectional Transil functions
- Breakdown voltage:
- VBR = 6.1 V min. and 25 V min.
- Low leakage current: < 1 mA
- Very small PCB area < 4.2 mm2 typically
- High ESD protection level: up to 25 kV
- High integration
- Pb-Free Package is Available
- S- Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

Complies with the following standards

IEC61000-4-2

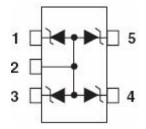
Level 4 16 kV (air discharge)

9 kV(contact discharge)

MIL STD 883E - Method 3015-7 Class 3

25 kV HBM (Human Body Model)





SOT-323-5

Applications

- Computers
- Printers
- Communication systems
- Cellular phones handsets and accessories
- Wireline and wireless telephone sets
- Set top boxes

Absolute Ratings (T_{amb}=25°C)

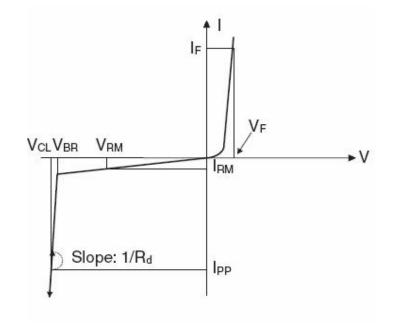
Symbol	Parameter	Value	Units
P _{PP}	Peak Pulse Power (tp= 8/20µs)	150	W
ΤL	Maximum lead temperature for soldering during 10s	260	°C
T _{stg}	Storage Temperature Range	-40 to +125	°C
T _{op}	Operating Temperature Range	-40 to +125	°C





Electrical Parameter

Symbol	Parameter	
V _{RM}	Stand-off voltage	
V _{BR}	Breakdown voltage	
V _{CL}	Clamping voltage	
I _{RM}	Leakage current	
I _{PP}	Peak pulse current	
I _R	Reverse current	
I _F	Forward current	
αΤ	Voltage temperature	
	coefficient	
V _F	Forward voltage drop	
С	Capacitance	
R _d	Dynamic	



Electrical Characteristics

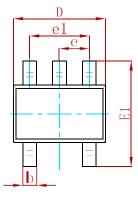
	V	BR		V _{RM}	I _{RM}	VF	IF	Rd	α Τ	С
P/N	Min.	Max.	I _R			Max.		Typ. ⁽¹⁾	Max. ⁽²⁾	Typ. 0v bias
	v	v	mA	v	μĄ	v	mA	Ω	10 ⁻⁴ /°C	pF
ESDA6V1W5-MS	6.1	7.2	1	5	1	1.25	200	0.61	6	90

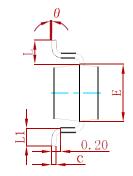
1. Square pulse I_{PP}=15A,t_p=2.5 μ s 2. V_{BR}=aT* (T_{amb}-25°C)*V_{BR}(25°C)

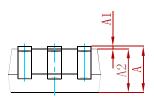


ESDA6V1W5-MS Semiconductor

PACKAGE MECHANICAL DATA

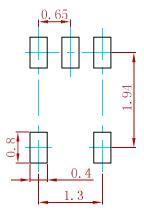






Cumula al	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	0.900	1.100	0.035	0.043	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.000	0.035	0.039	
b	0.150	0.350	0.006	0.014	
С	0.100	0.150	0.004	0.006	
D	2.000	2.200	0.079	0.087	
E	1.150	1.350	0.045	0.053	
E1	2.150	2.400	0.085	0.094	
е	0.650 TYP		0.026	5 TYP	
e1	1.200	1.400	0.047	0.055	
L	0.525 REF		0.021 REF		
L1	0.260	0.460	0.010	0.018	
θ	0°	8°	0°	8°	

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:±0.05mm.

3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
ESDA6V1W5-MS	SOT-323-5	3000



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